

# Two Photon Absorption & Carrier Generation in Semiconductors

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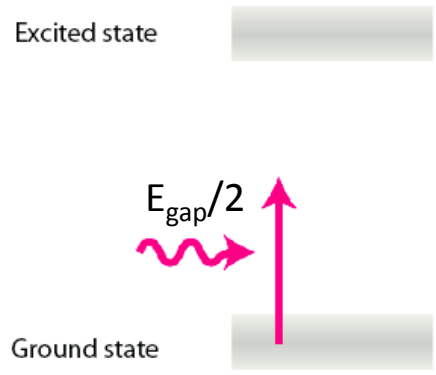
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## Two Photon Absorption (TPA)

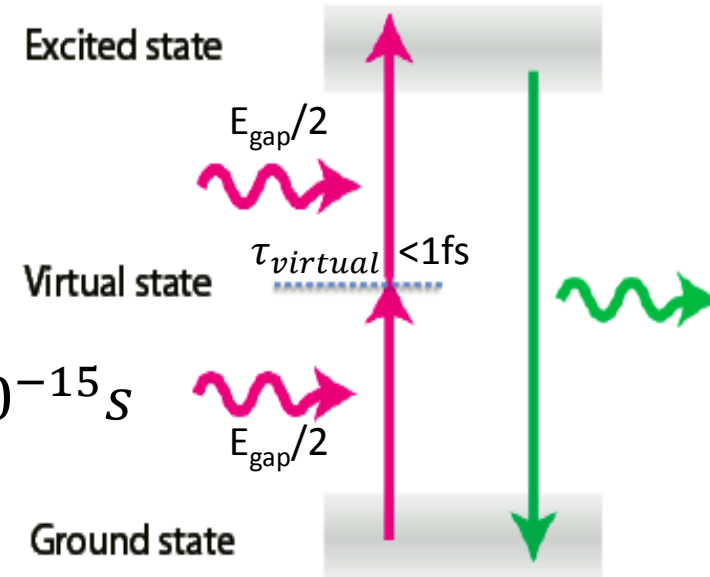
### Origins

Conventionally, no excitation if  $E_{\text{photon}} < E_{\text{gap}} \sim 1\text{eV}$

But if TWO photons arrives in  $\sim 100$  attoseconds



$$\tau_{\text{virtual}} \sim \frac{\hbar}{E_{\text{gap}}/2} \sim 0.1 \times 10^{-15} \text{ s}$$



### One vs Two-photon Excitation

In 1931, it was predicted theoretically by Maria Goppert-Mayer [1], in her PhD dissertation, that due to the time-energy uncertainty principle, forbidden under gap single photon atomic transitions ( $h\nu < E_{\text{gap}}$ ) can be possible adding the energy of two almost simultaneous photons ( $2h\nu > E_{\text{gap}}$ ) through intermediate “virtual” states. In fluorescent molecules, two photon pumping was demonstrated by Webb et al in 1990 [2] by detection of the fluorescence photon. Refocusing the optics in depth, we can obtain a Z-scan, by Prof. Eric W. Van Stryland and Prof. David J. [3].

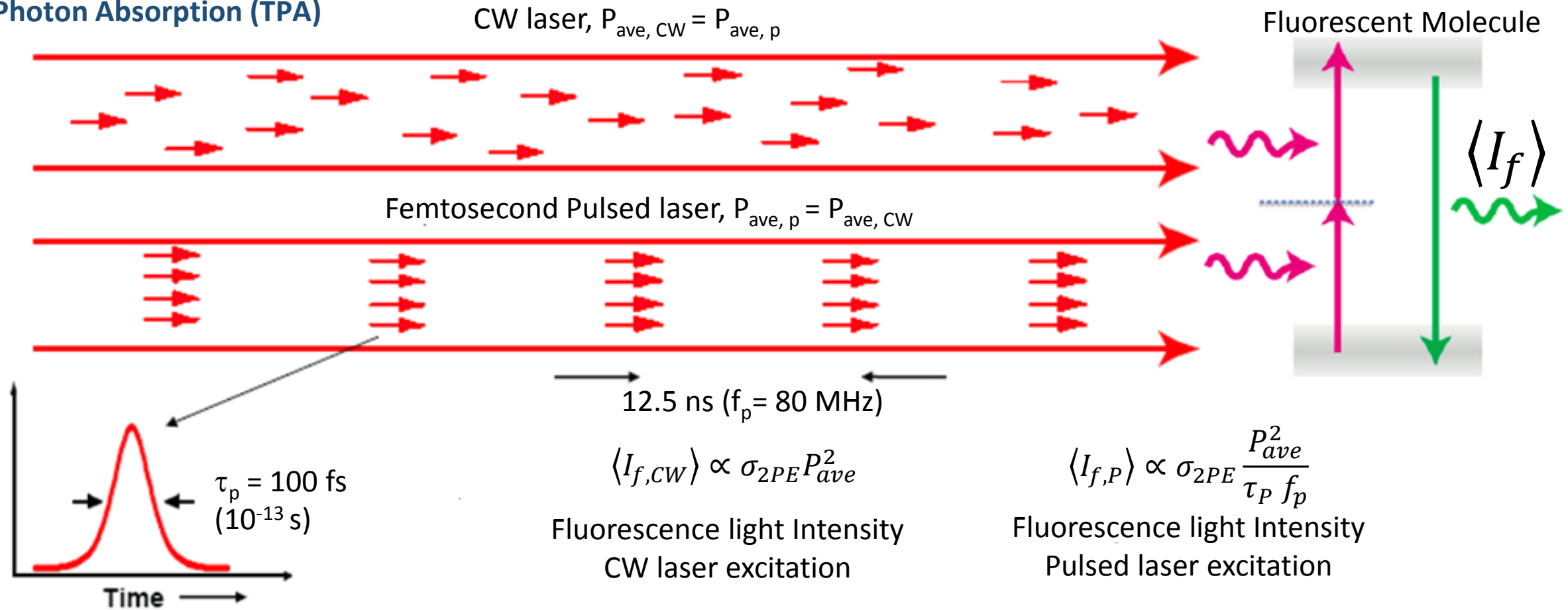
#### References:

- [1] M. Goppert-Mayer, *Ann. Phys.*, 1931, **9**, 273-294.
- [2] W. R. Zipfel, R. M. Williams, W. W. Webb, *Nat. Biotechnol.*, 2003, **21**, 1369-1377.
- [3] M. Sheik-Bahea, A. A. Said, T. H. Wei, D. J. Hagan, E. W. Van Stryland, *IEEE J. Quantum Electronics*, 1990, **26**, 760-769.



Maria Goppert-Mayer  
1963 Nobel Prize in Physics

### Lasers for Two Photon Absorption (TPA)



The probability of a two photon absorption is increased by  $(1/\tau_p f_p) = 10^5$  for the same average power by using a mode-locked pulsed laser

Two-photon fluorescence excitation and related techniques in biological microscopy, A.Diaspro et al., Quarterly Reviews of Biophysics 38(29) 2005, pp 97-166

## Z scan Technique A Photochemistry Illustrative Example

### 2PA in organic liquids

Ti:Sapphire Laser

200 fs, 760 nm, 76 MHz Rep. Rate

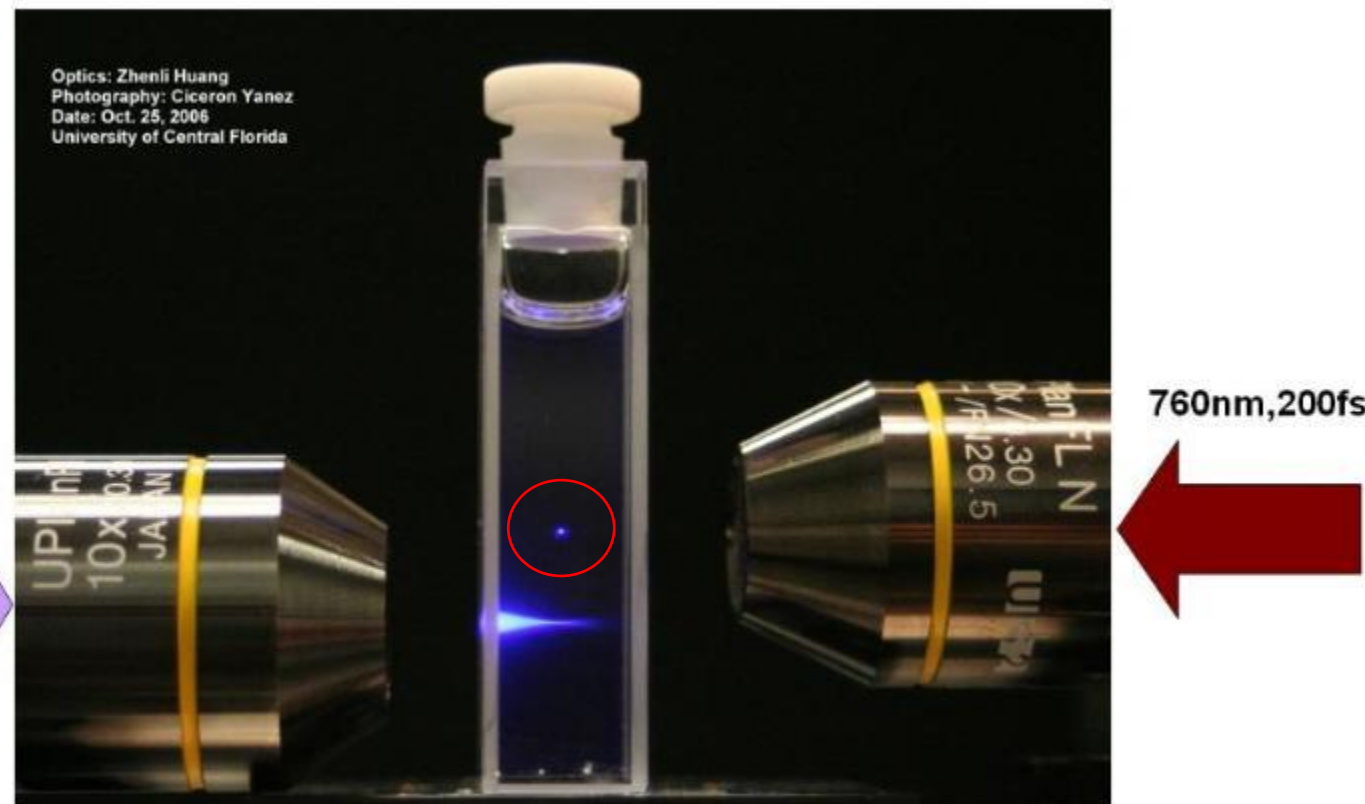
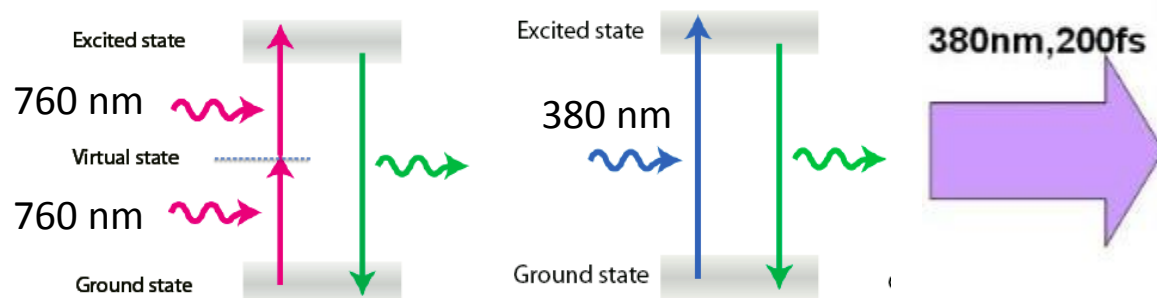
Raw Focusing on Fluorene 3:

*Two Photon Absorption Induced Fluorescence*

With a second harmonic generator

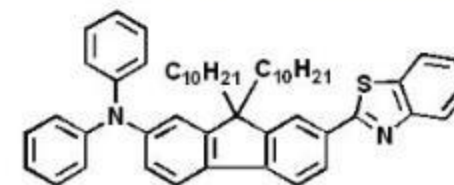
200 fs, 380 nm, 76 MHz Rep. Rate

*One Photon Absorption Induced Fluorescence*



**SPA signature: a diffraction Rayleigh cone**  
**TPA signature: a single blue dot**

Fluorene 3



<http://chemistry.cos.ucf.edu/belfield/photophysics>

## Z scan Technique Funny and Useful!

### SubSurface Laser Engraving (SSLE)

Typically in BK7 Glass (Borosilicate doped with potassium)

Also with pure quartz ( $\text{SiO}_2$ )

Pico or FemtoSecond Laser, 1064 nm ( $\text{SiO}_2$ ), 532 nm (BK7)

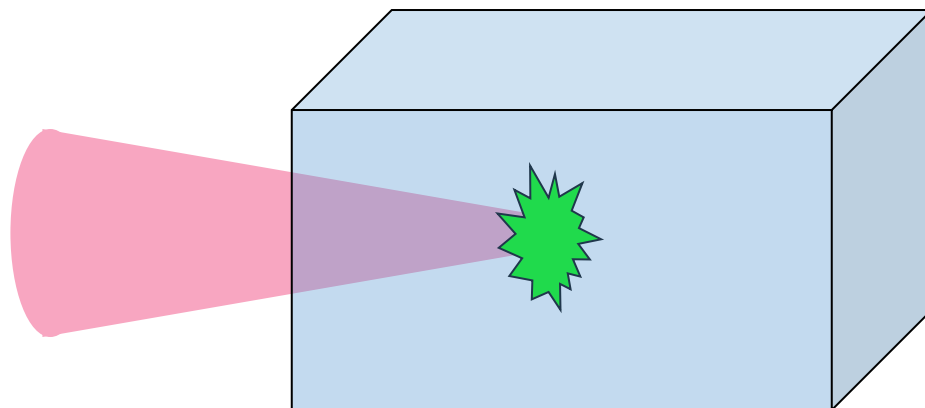
Multi-Photon Absorption

Free electron creation in the focus point

FotoChemistry in Solids:

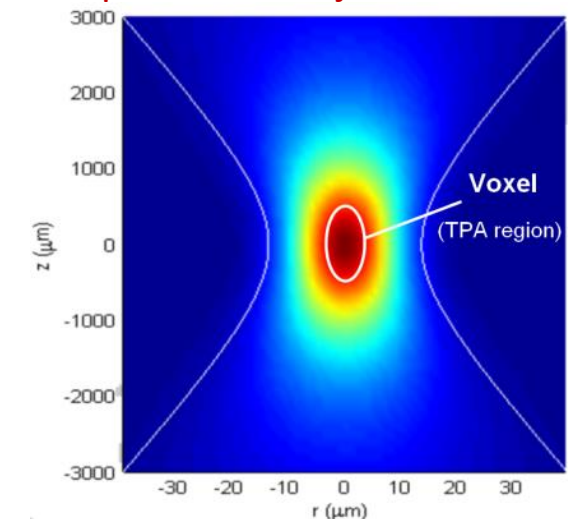
Index of refraction changes,

Color centers



TJDP-532K Machine (532 nm, BK7 crown glass)

<http://www.tianjunlaser.com/>



*Two-Photon Photopolymerization and 3D Litographic Microfabrication.* H.B.Sun and S.Kawata. APS (2004) 170 pp 169-273, Springer-Verlag.  
*Femtosecond Laser Litography in Organic and Non-Organic Materials*, F.Jipa et al., Chap.3, Nanotechnology and Nanomaterials, "Updates in Advanced Litography", ed. by S.Hosaka, INTECH, 2013.



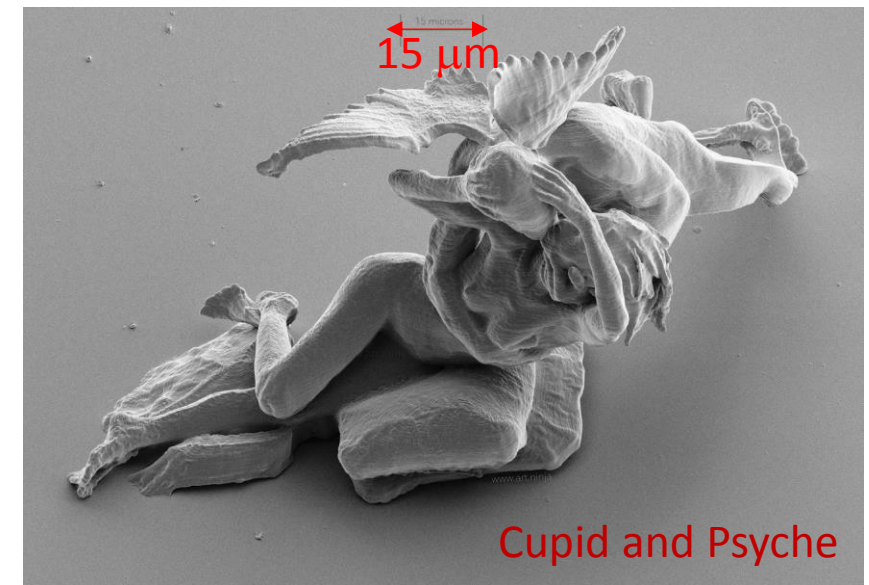
## Z scan Technique 3D Litography

### 3D Litography

If you illuminate a light-sensitive polymer with Ultra Violet wavelengths, it solidifies wherever it was irradiated in a kind of crude lump. It's the process your dentist uses when your filling is glued in with a UV light.

If however you use longer wavelength intense light, and focus it tightly through a microscope, something wonderful happens: at the focus point, the polymer absorbs TWO PHOTONS and responds as if it had been illuminated by UV light, namely it will solidify. This two photon absorption occurs only at the tiny focal point - basically a tiny 3D pixel (called a Voxel). The sculpture is then moved along fractionally by a computer controlled process and the next voxel is created. Slowly, over hours and hours the entire sculpture is assembled voxel by voxel and layer by layer.

Jonty Hurwitz, TPA nano-sculptor,  
<http://www.jontyhurwitz.com/nano>



## Two Photon Absorption (TPA) Silicon

- In solid state, fast (ps) optical excitation generates electron-hole carriers.
- If the laser pulse wavelength is sub-bandgap the material is transparent to the optical pulse.
- Carriers are generated (TPA) by nonlinear absorption at high pulse irradiances by the simultaneous absorption of two photons
- Carriers are highly concentrated in the high irradiance region near the beam focus

$$\frac{dI(r, z)}{dz} = -\alpha I(r, z) - \beta_2 I^2(r, z) - \sigma_{ex} N I(r, z)$$

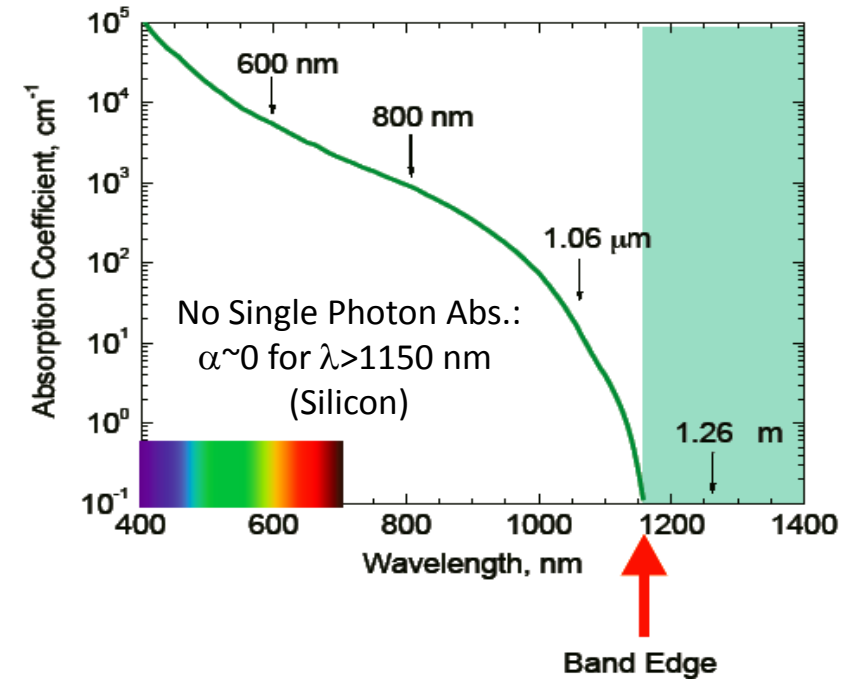
Optical Absorption Equation

$$\frac{d\Phi(r, z)}{dz} = \beta_1 I(r, z) - \gamma_1 N(r, z)$$

Phase Change by free carriers

$$\frac{dN(r, z)}{dt} = \frac{\alpha I(r, z)}{\hbar\omega} + \frac{\beta_2 I^2(r, z)}{2\hbar\omega}$$

Carrier Generation equation



And free carrier absorption ( $\sigma_{ex}$ ) is negligible if we avoid heavily doped volumes ( $<1E20 \text{ cm}^{-3}$ ), so the TPA carrier generation goes as:

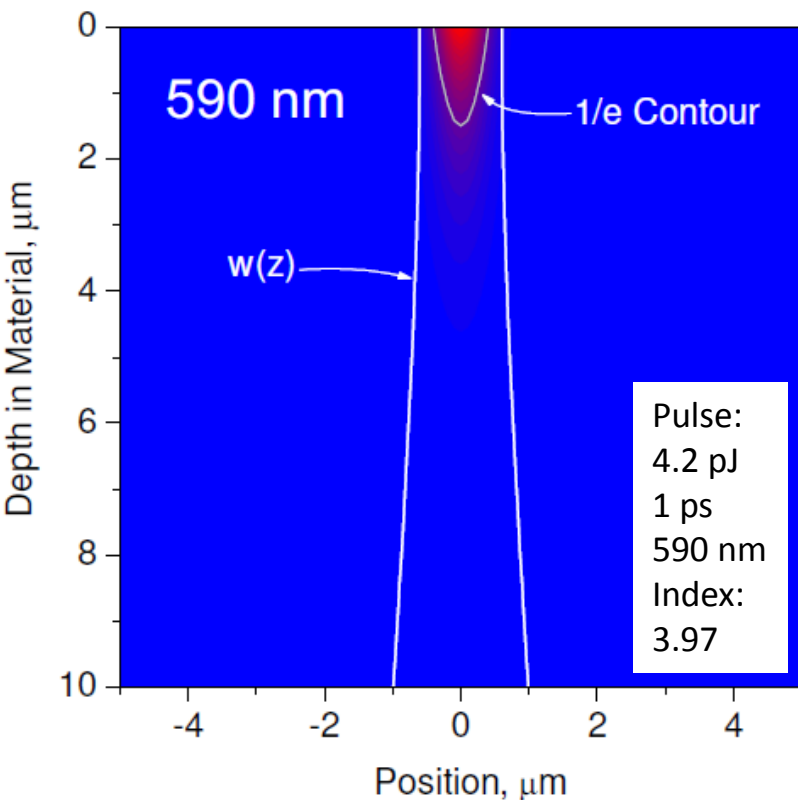
$$\frac{dN_{2P}(z)}{dt} = \frac{\beta_2}{2\hbar\omega} I^2(z, t) \quad ; \quad I(z) = \frac{I_o}{1 + \beta_2 I_o z}$$

$$N_{2P}(z) = \frac{\beta_2}{2\hbar\omega} \int_{-\infty}^{\infty} I^2(z, t) dt$$

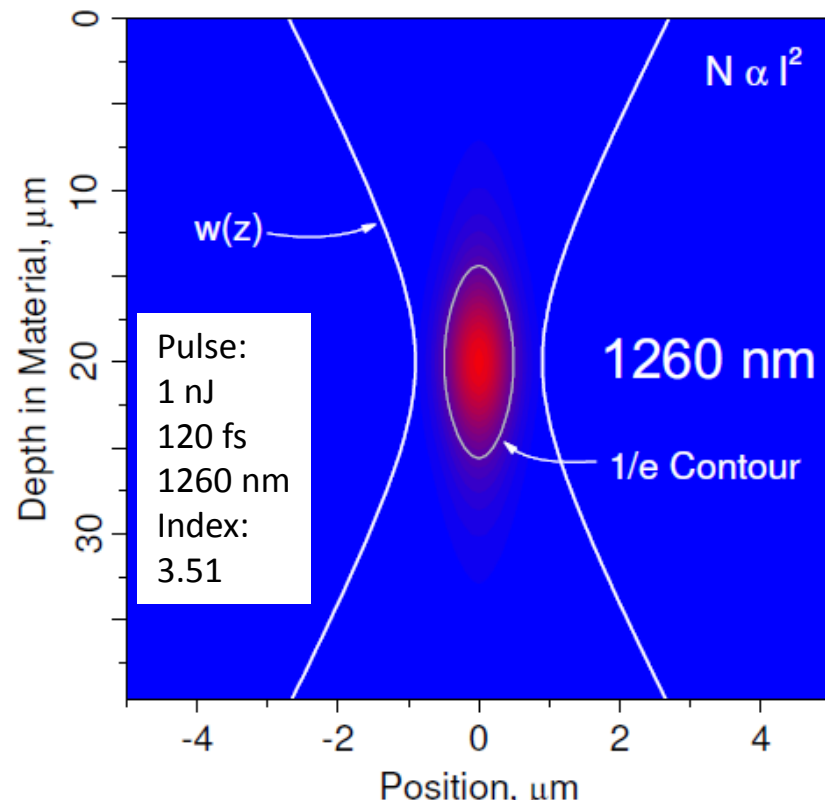
*Subbandgap Laser-Induced Single Event Effects: Carrier generation via two photon absorption.* D.M.McMorrow et al. IEEE Transactions on Nuclear Science, 49 (6) Dec 2002, pp 3002-3007.

*Laser Simulation of Single-Event Effects: A state of the art review,* S.Buchner, Army Research Laboratory, ARL-CR-185

### TPA in Silicon Gaussian Pulse (TM00) Femtosecond Laser

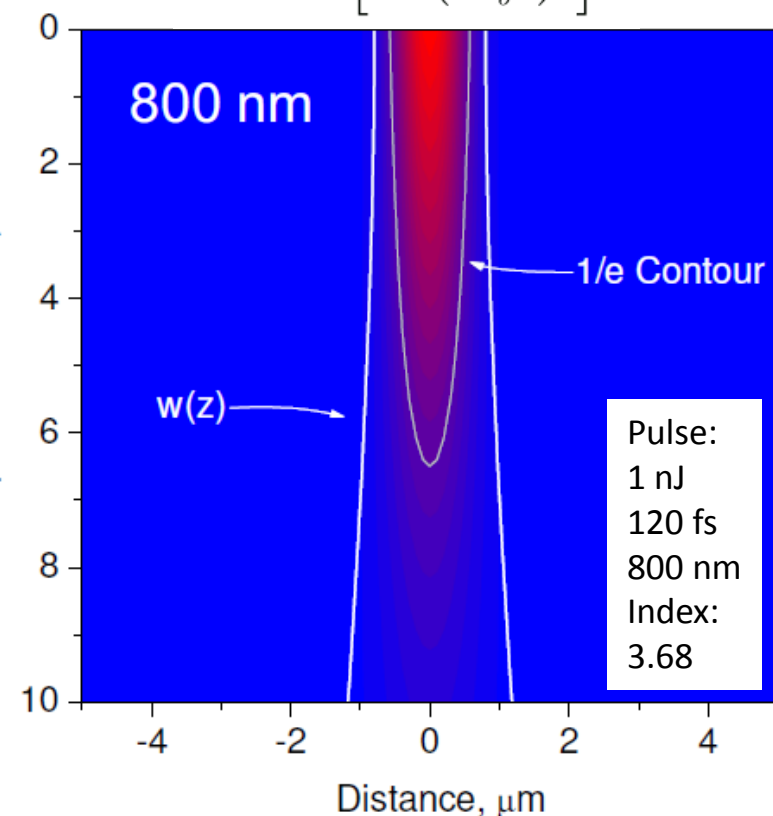


All of them focused to a diameter of 1.2 μm



$$I(r, z) = \frac{2P}{\pi w^2} \exp(-2r^2/w^2)$$

$$w(z) = w_0 \left[ 1 + \left( \frac{\lambda z}{\pi w_0^2 n} \right)^2 \right]^{1/2}$$



$$N_{1P}(z) = \frac{\alpha}{\hbar\omega} \exp(-\alpha z) \int_{-\infty}^{\infty} I_o(z, t) dt$$

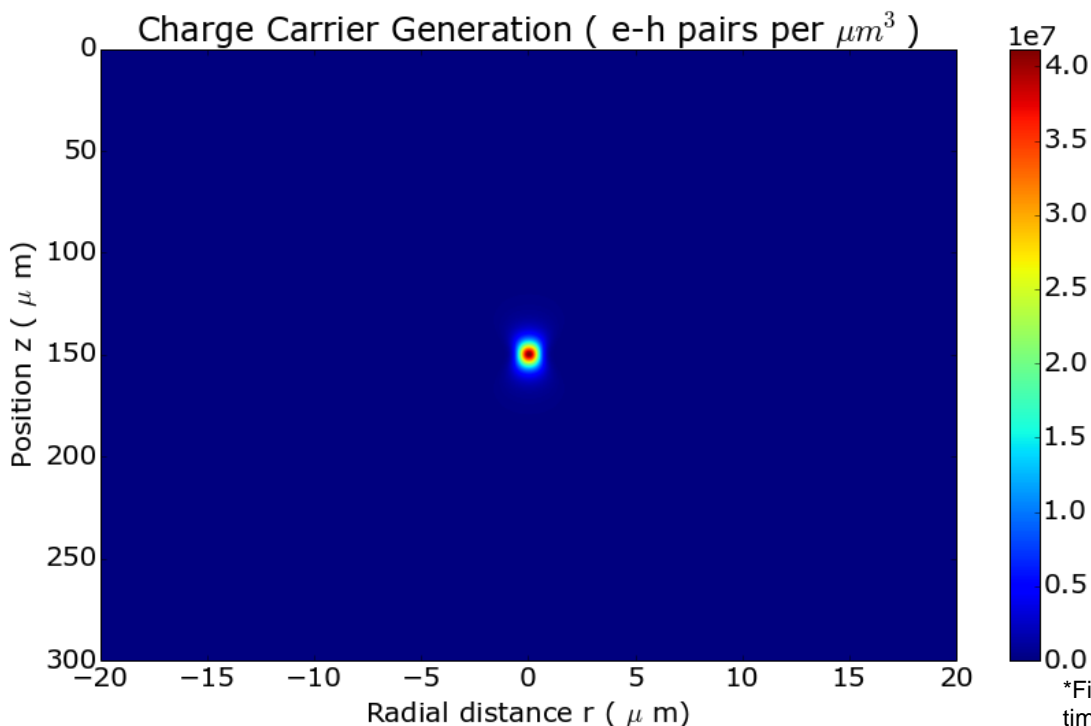
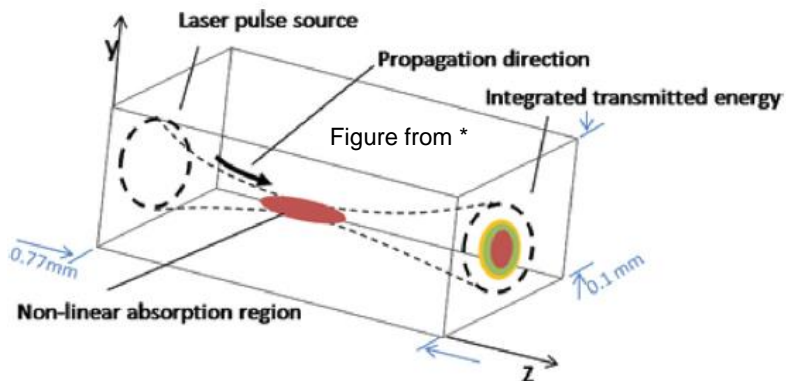
$$N_{2P}(z) = \frac{\beta_2}{2\hbar\omega} \int_{-\infty}^{\infty} I^2(z, t) dt$$

$$N_{1P}(z) = \frac{\alpha}{\hbar\omega} \exp(-\alpha z) \int_{-\infty}^{\infty} I_o(z, t) dt$$

Single Event Effect Induced by Two-Photon Absorption: Overview and Current Status. D.M.McMorrow et al. RADECS 2004, Madrid, Spain, 22nd-24th September, 2004.



## TPA in Silicon Gaussian Pulse (TM00) Femtosecond Laser



$\tau = 120 \text{ fs}$   
 $\beta = 0.3 \text{ cm/GW}$   
 $\text{Power} = 1. \text{e-}9 / 120 \text{e-}15 \text{ W}$   
 $\lambda = 1300 \text{ nm}$   
 $w_0 = 0.947 \text{e-}6 \text{ m}$   
 $n(\text{Si}) = 3.51$   
 $z_0 = 150 \text{e-}6 \text{ m}$

**Gaussian Intensity Profile**

$$w(z)^2 = w_0^2 \left[ 1 + \left( \frac{\lambda z}{\pi w_0^2 n} \right)^2 \right]$$

$$I(r, z) = \frac{2P}{\pi w(z)^2} \exp \frac{-2r^2}{w(z)^2}$$

**TPA absorption (negligible attenuation)**

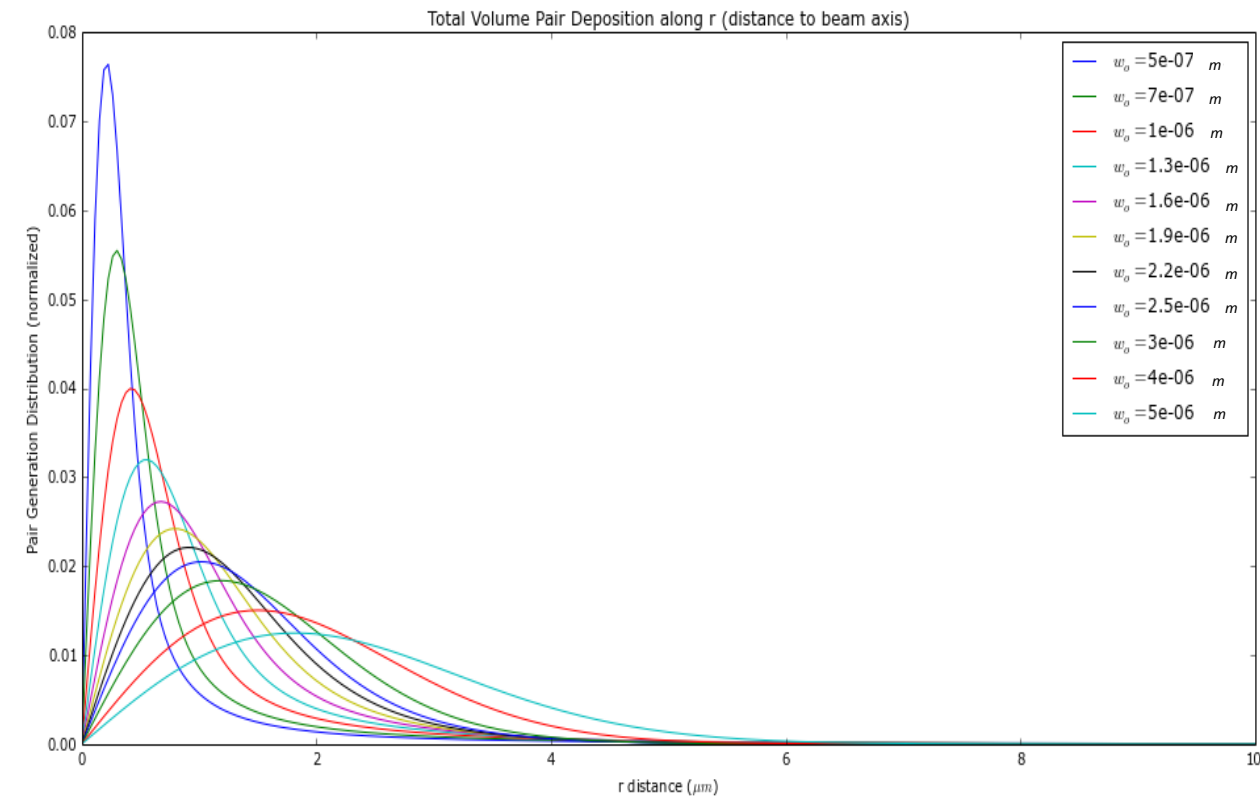
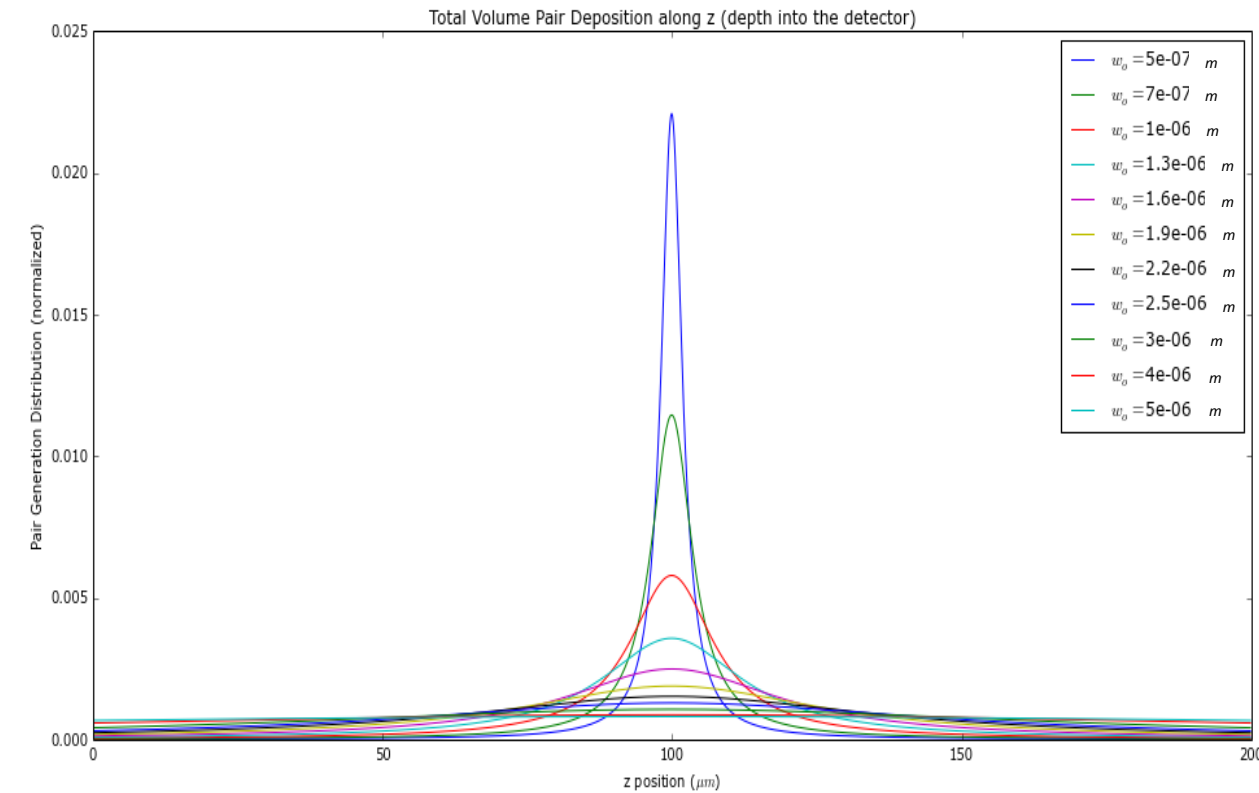
$$n_{TPA}(z) = \frac{\beta \tau}{2\hbar\omega} I(r, z)^2$$

**TOTAL NUMBER OF PAIRS GENERATED IN THE DETECTOR**

$$N_{total} = \int_{z=200\mu\text{m}}^{z=0\mu\text{m}} \int_{r=60\mu\text{m}}^{r=0\mu\text{m}} \int_{\phi=2\pi}^{\phi=0} n_{TPA}(z, r) r d\phi dr dz$$

\*Figure from "Non-linear absorption of 1.3-um wavelength femtosecond laser pulses focused inside semiconductors: Finite difference time domain-two temperature model combined computational study" I.B.Bogatyrev ,D.Grojo, P.Delaporte, S.Leyder, M.Sentis, W.Marine, T.E.Itina J.Appl.Phys. 110, 103106 (2011)

## Focus effect on depth/radial distribution



### DEPTH PROFILE OF PAIR DEPOSITION

$$N_z(z) = \int_{r=60\mu\text{m}}^{r=0\mu\text{m}} \int_{\phi=2\pi}^{\phi=0} n_{TPA}(z, r) r dr d\phi dz$$

$$\begin{aligned} \tau &= 120 \text{ fs} \\ \beta &= 0.3 \text{ cm/GW} \\ \lambda &= 1300 \text{ nm} \\ n(\text{Si}) &= 3.51 \end{aligned}$$

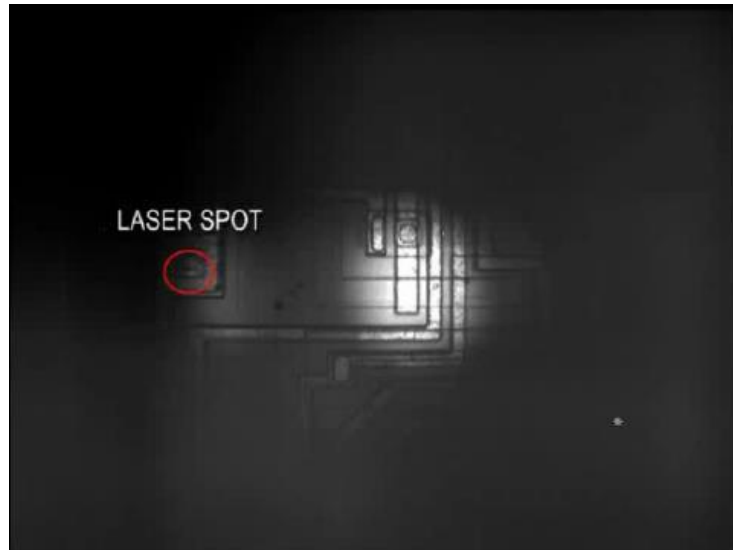
### RADIAL PROFILE OF CHARGE DEPOSITION

$$N_r(r) = \int_{z=200\mu\text{m}}^{z=0\mu\text{m}} \int_{\phi=2\pi}^{\phi=0} n_{TPA}(z, r) r dr d\phi dz$$

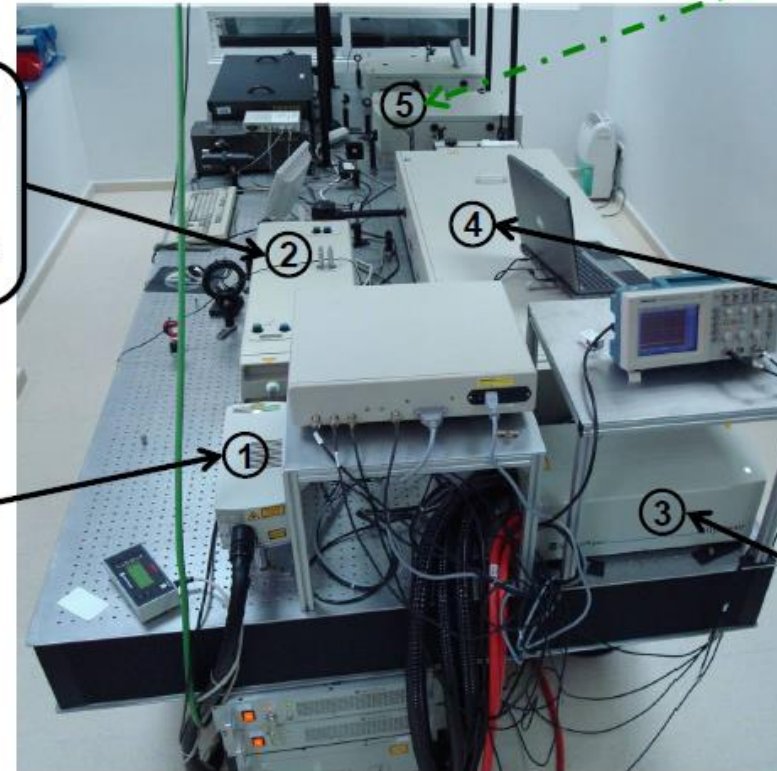
## Z-scan for SEE in microelectronics

We had experience of TPA absorption in silicon devices (microelectronics) during the Spanish Project:

**EMULASER PN-PROFIT**  
**PNE-034/2006 ,**  
**31/12/2006 – 10/09/2009**



### Femtosecond LASER Pulse



**Femtosecond Oscillator "Tsunami"**  
 Ti:Zafire 430 mW, 800 nm, 80 MHz, 50 fs/pulse

**Pumped LASER "Millenia"**  
 Nd:Vanadate  
 5W, 532 nm

**Main feature!**  
**Optical Parametric Amplifier "OPA"**  
 Tunable Wavelength from UV (300 nm) to IR (3 μm)

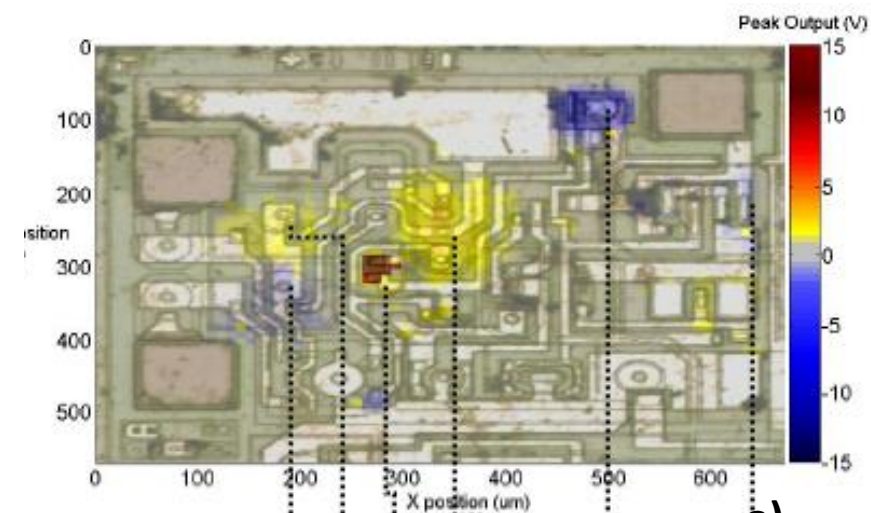
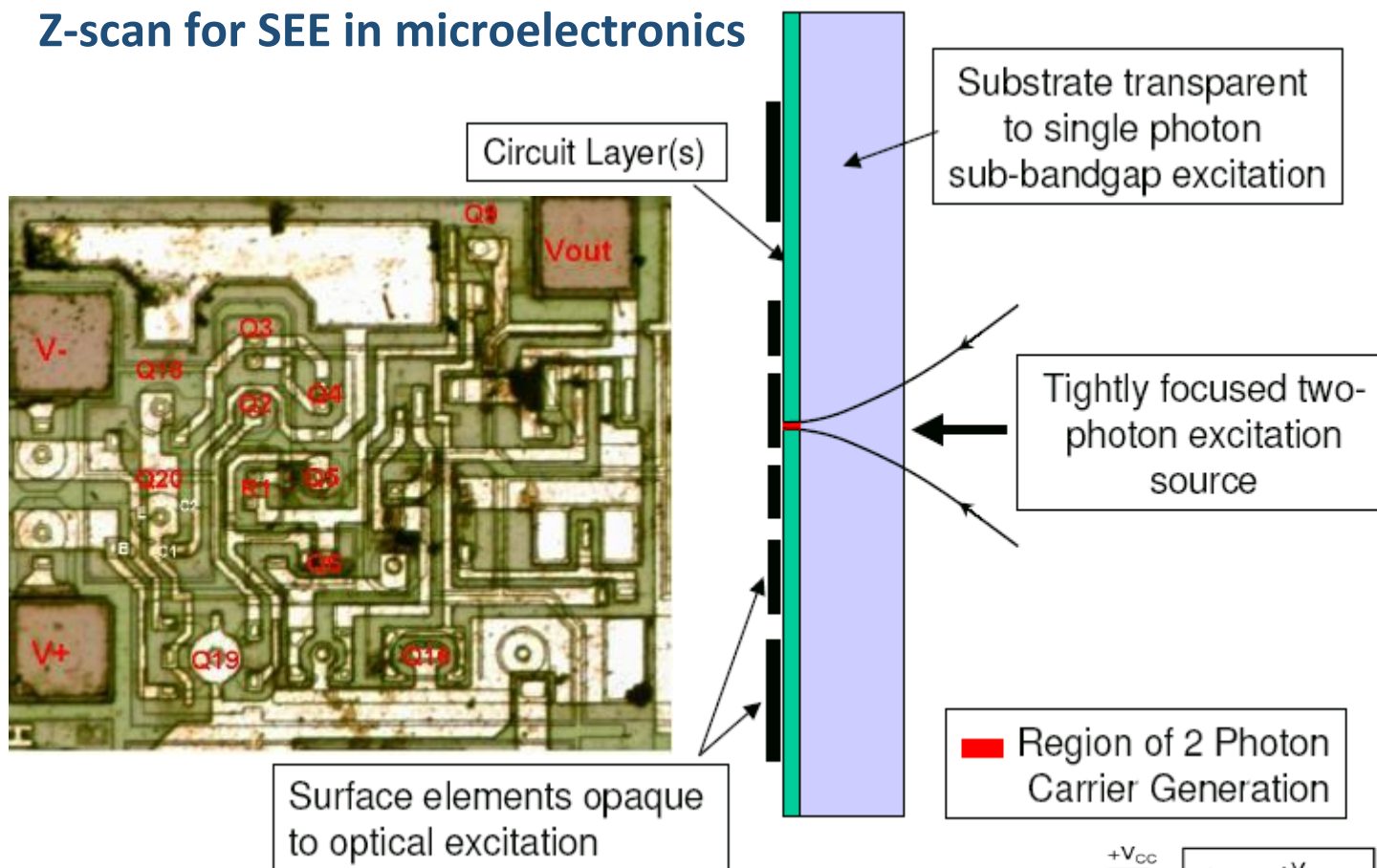
**Regenerative Amplifier "Spitfire"**  
 Ti:Zafire 3.6 mJ/pulse, 800 nm, 1 KHz, 35 fs/pulse

**Pumped LASER "Empower"**  
 Nd:YLF  
 20 mJ/pulse, 527nm, 1 KHz

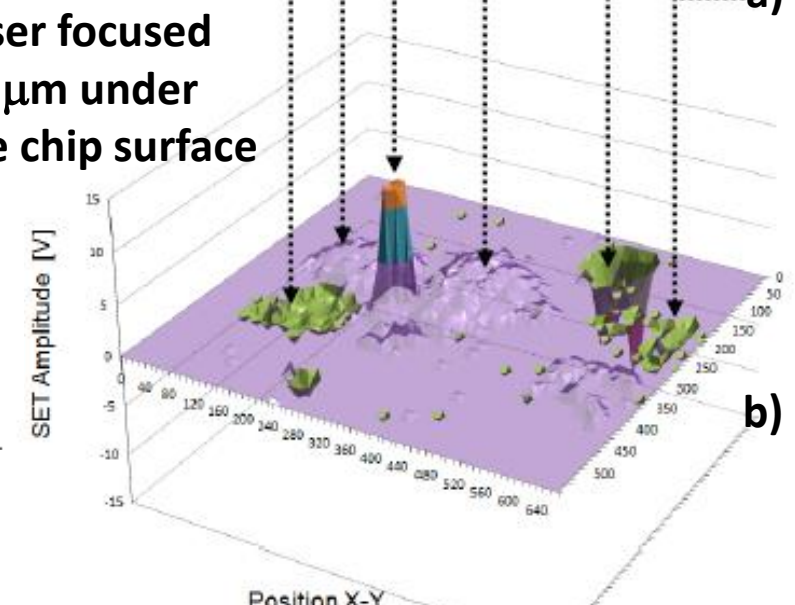
**TPA Laser @ University Complutense of Madrid**



### Z-scan for SEE in microelectronics

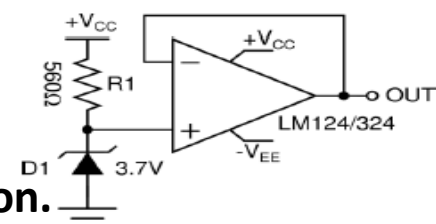


Laser focused 50 μm under the chip surface



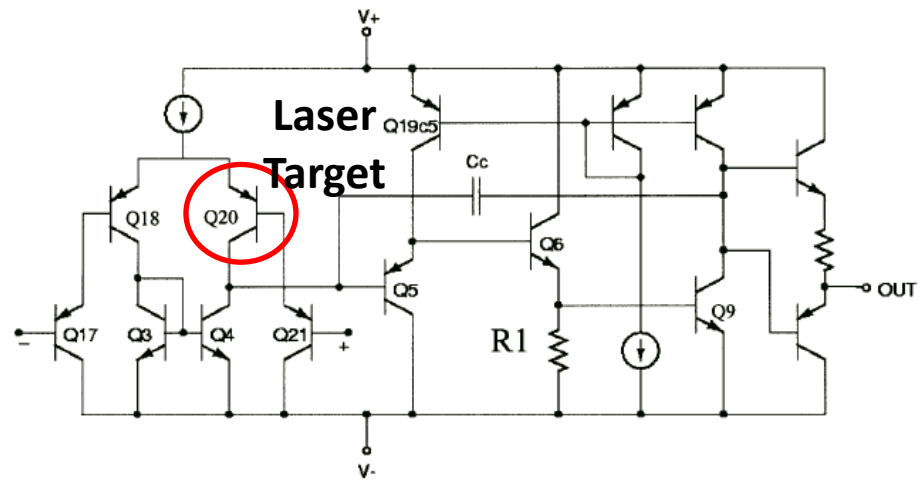
Example of a 2D (a) and a 3D (b) SEE sensitive map after a Laser scan over a LM324 opamp, voltage follower configuration.

Laser Parameters:  $\lambda=1300$  nm,  $E_p=0,6$  nJ



*Emulación de los efectos de la radiación ionizante en dispositivos analógicos mediante láser pulsado de femtosegundo sintonizable. Tesis Doctoral, Isabel López Calle, Facultad de Física, Universidad Complutense de Madrid., Madrid 2010*  
**Two Photon Absorption (TPA) Backside Pulsed laser tests in the LM324.** I.López-Calle et al. Proceedings of RADECS'09, Bruges, Belgium, September 2009

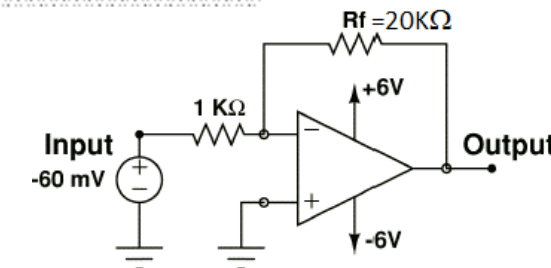
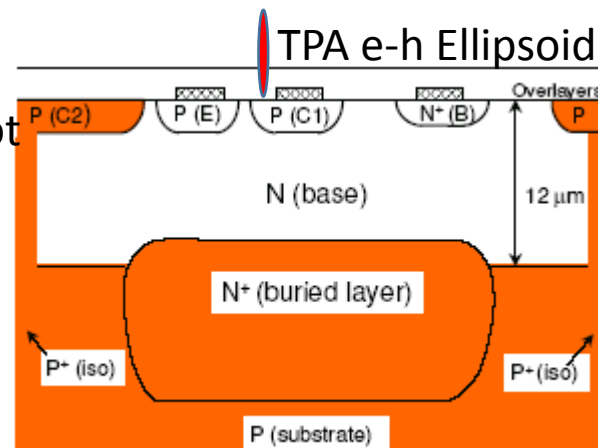
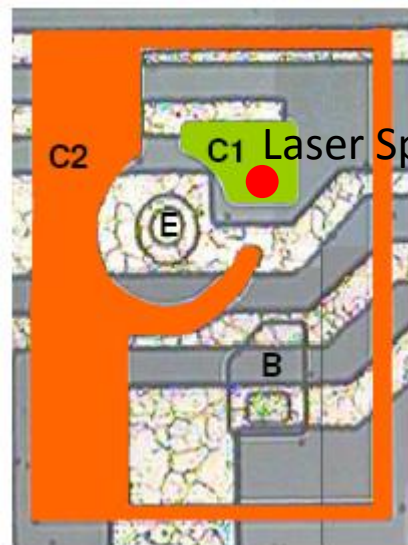
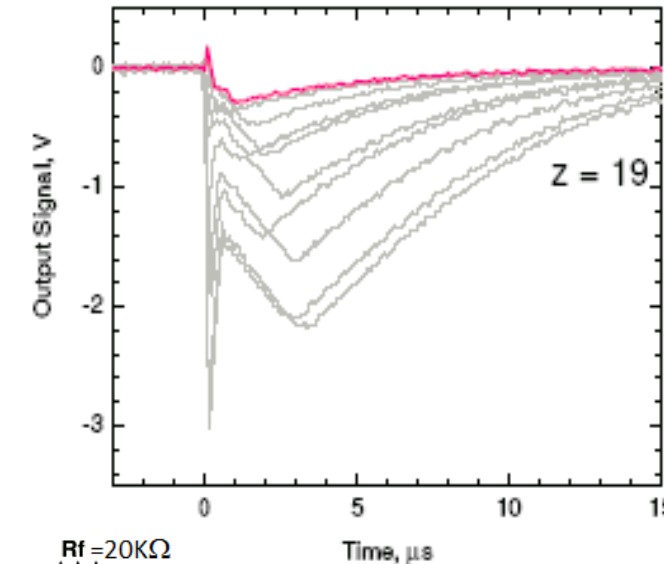
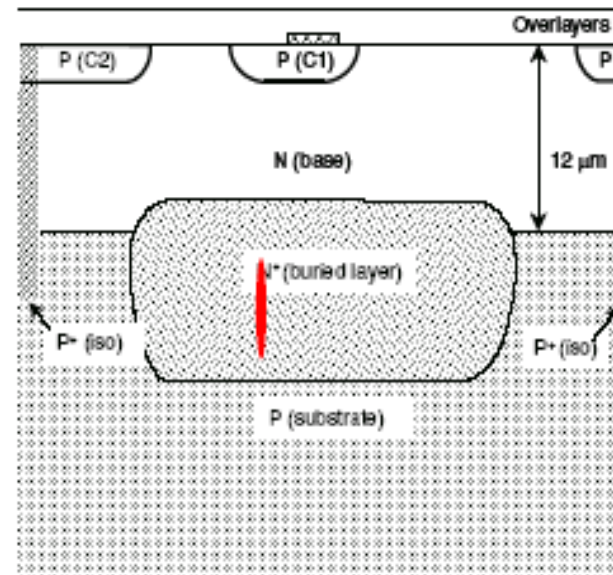
### Z-scan for SEE in microelectronics



LM124 Op-Amp Inverting configuration, gain of 20

$$V_{dd} = \pm 15 \text{ V}, V_{in} = 5 \text{ mV}$$

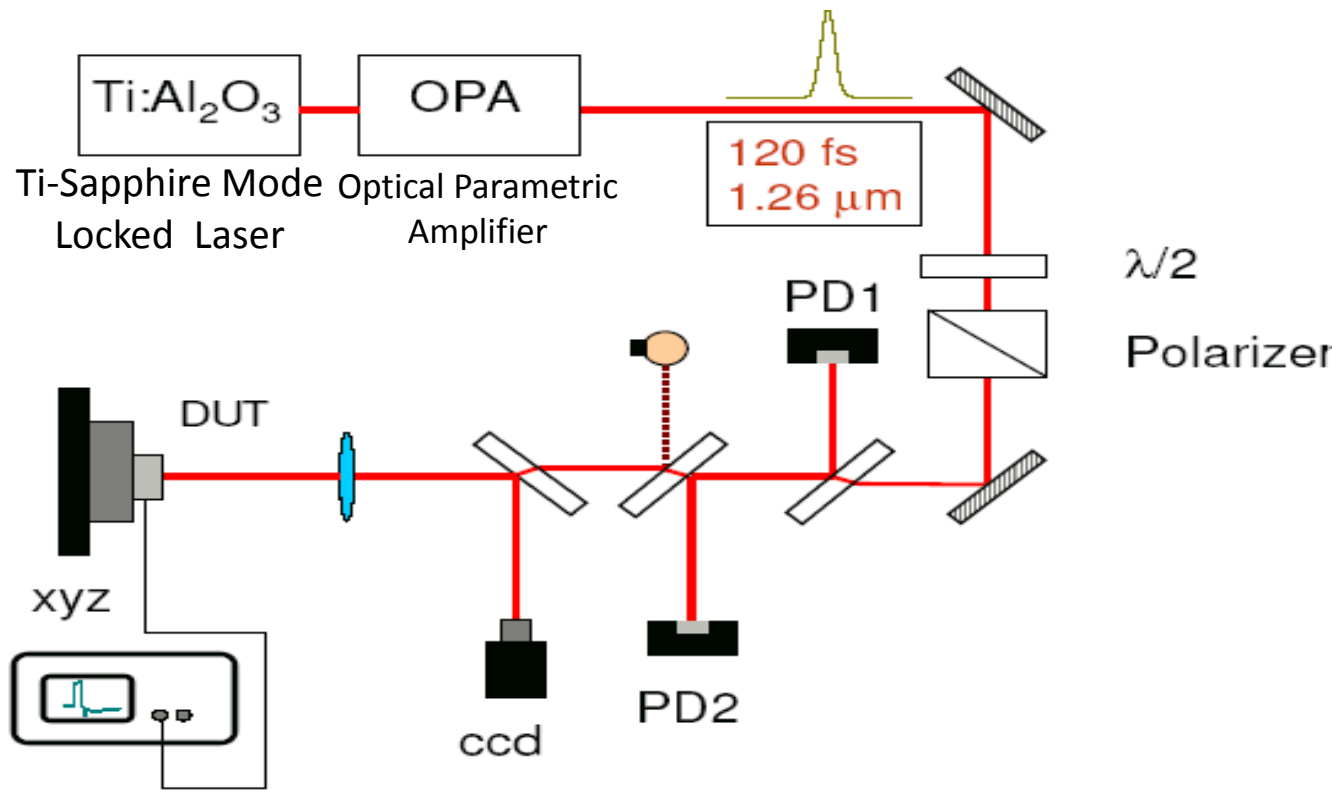
1260 nm, 120 fs pulsed laser, focused on Q20



2004 Proceedings of the 6th International Workshop on Radiation Effects on Semiconductor Devices for Space Applications. D.M.McMorrow et al. RASEDA 2004, Tsukuba, Japan, 6th-8th October, 2004.



### General Layout and Availability



Example: PULSBOX  
 Turn-key Smart Laser Source for Pulsed Laser Stimulation  
 (1300 nm)  
 From PULSCAN ([www.pulscan.com](http://www.pulscan.com))  
 < 100.000 €

## Conclusions

- Laser TPA regularly used in TPA fluorescence microscopy
- Laser TPA used since 10 years ago for SEE studies in Silicon microelectronics
  - There is industrial equipment for Pulsed Laser interaction in TPA mode
  - **Now, we propose to use Laser TPA as a new TCT technique:**

## TPA-TCT

See the presentation about the experimental demonstration of TPA-TCT: ***“TPA-TCT, A novel Transient-Current-Technique based on the Two Photon Absorption Process”***, P.Castro, M.Fernández, J.González, R.Jaramillo, M.Moll, R.Montero, F.R.Palomo, I.Vila, 25th RD50 General Meeting, November 19th-21st, 2014, CERN  
<https://indico.cern.ch/event/334251/session/1/contribution/35/material/slides/0.pptx>



**Thanks for your attention**

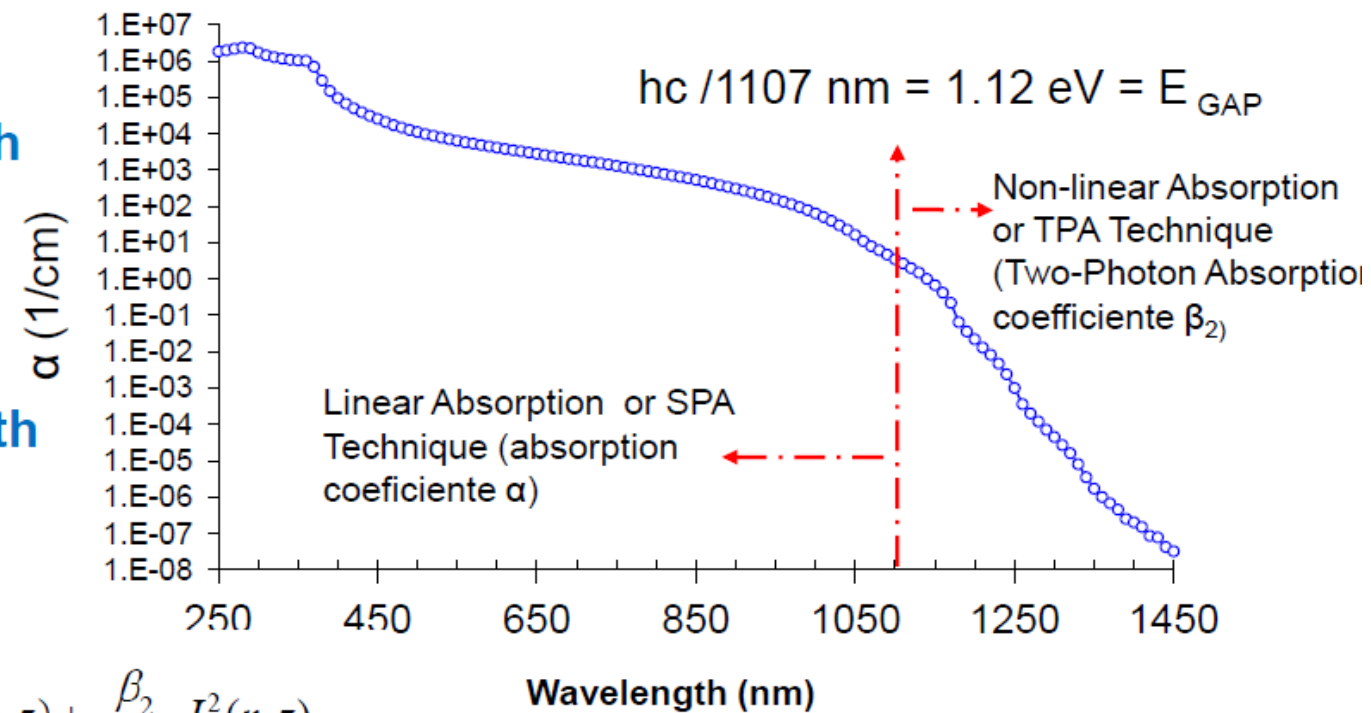
[fpalomop@cern.ch](mailto:fpalomop@cern.ch)

Regarding to the wavelength



We can use both SPA & TPA techniques

Absorption Coefficient of Silicon



$$\frac{dN(r, z)}{dt} = \frac{\alpha}{E\gamma} I(r, z) + \frac{\beta_2}{2 \cdot E\gamma} I^2(r, z)$$

Technique	Advantages	Disadvantages
SPA (Single Photon Absorption)	$\alpha$ is well known.	Low penetration
TPA (Two Photon Absorption)	Any level of penetration	$\beta_2$ is not well Known. Under investigation

Energy band-gap dependence of two-photon absorption, E.W. Van Stryland et al. Optics Letters, 10(10) Oct.1985, pp.490-492

## Two photon absorption coefficient $\beta_2$

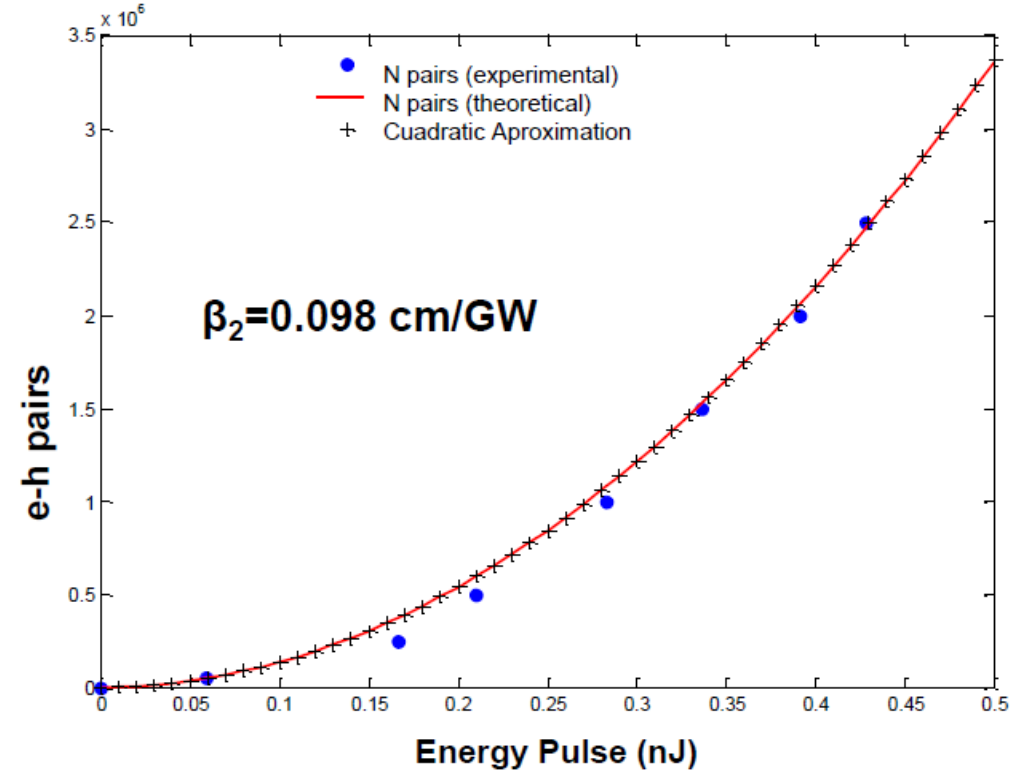
$\beta_2$  is defined as the probability of simultaneous absorption of two photons.

It differs from linear absorption  $\alpha$  in that the absorption depends on the square of the light intensity, thus it is a nonlinear optical process.

Carrier generation equation:

$$\frac{dN(r, z)}{dt} = \frac{\alpha I(r, z)}{\hbar\omega} + \frac{\beta_2 I^2(r, z)}{2\hbar\omega}$$

$$N_{pairs} = \frac{T^2 \cdot \beta_2 \cdot d}{2E_\gamma \cdot s \cdot t} E_p^2$$



Reference	Li07	Br07	Xu99	Mo92	Bo86
$\beta_2$ (cm/GW)	0.55	1.6	1	0.1	1
Type	Exp.	Exp.	Exp.	Teo.	Exp

Effective value of  $\beta_2$  = measured at device output signal

*Emulación de los efectos de la radiación ionizante en dispositivos analógicos mediante láser pulsado de femtosegundo sintonizable. Tesis Doctoral, Isabel López Calle, Facultad de Física, Universidad Complutense de Madrid., Madrid 2010*